


<b>Search Notes</b>  	<b>Application/Control No.</b>  10629596	<b>Applicant(s)/Patent Under Reexamination</b>  SHIOZAWA ET AL.
	<b>Examiner</b>  Tu, Julia P	<b>Art Unit</b>  2611

SEARCHED			
Class	Subclass	Date	Examiner
375	295	11/18/2006	J.T.
370	466	11/18/2006	J.T.
375	371, 376,316	4/17/2007	J.T.
327	147	4/17/2007	J.T.
370	395.62,395.6,503,314,328,156,474,545	4/17/2007	J.T.

SEARCH NOTES		
Search Notes	Date	Examiner
Inventors name searched	11/18/2006	J.T.
Searched on East using US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM, TDB	11/18/2006	J.T.
Searched on Google, IEEE	11/20/2006	J.T.
Consulted with Chieh Fan and Khanh Tran	11/20/2006	J.T.
Consulted with Chau Nguyen, SPE (370) on the allowance of claims 4-6	11/21/2006	J.T.
update search on East	4/17/2007	J.T.
consult with Chieh Fan	4/17/2007	J.T.

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
370	395.62,395.6,503,314,328,156,474,545	4/17/2007	J.T.
375	371,376,316	4/17/2007	J.T.
327	147	4/17/2007	J.T.